

TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

TA78L05S, TA78L07S, TA78L08S, TA78L09S TA78L10S, TA78L12S, TA78L15S

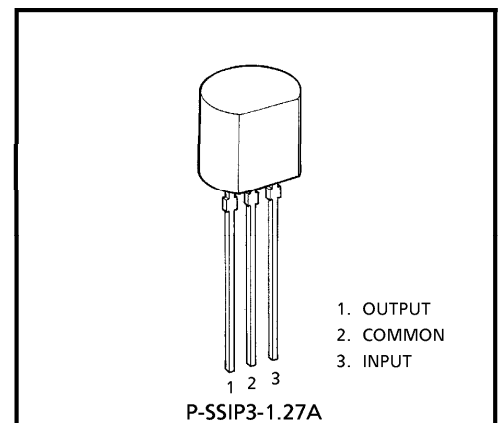
THREE TERMINAL POSITIVE VOLTAGE REGULATORS

5 V, 7 V, 8 V, 9 V, 10 V, 12 V, 15 V

The TA78Lx xS series of fixed voltage monolithic integrated circuit voltage regulators is designed for a wide range of applications.

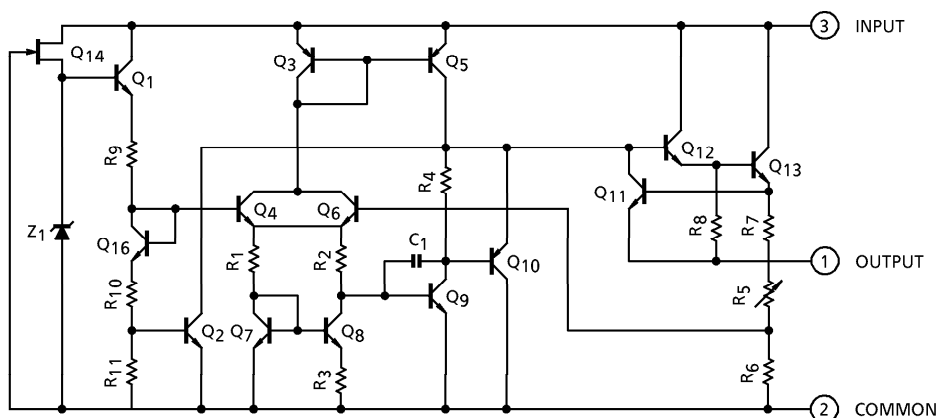
FEATURES

- Suitable for TTL, C²MOS Power Supply
- Internal Short-Circuit Current Limiting
- Internal Thermal Overload Protection
- Maximum Output Current of 100 mA ($T_j = 25^\circ\text{C}$)
- TO-92 Package



Weight : 0.21 g (Typ.)

EQUIVALENT CIRCUIT



980910EBA1

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MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Input Voltage	V _{IN}	35	V
Power Dissipation (Ta = 25°C)	P _D	600	mW
Operating Temperature	T _{opr}	– 30~85	°C
Storage Temperature	T _{stg}	– 55~150	°C
Junction Temperature	T _j	150	°C
Thermal Resistance	R _{th(j-a)}	208	°C / W

TA78L05S

ELECTRICAL CHARACTERISTICS

(Unless otherwise specified, V_{IN} = 10 V, I_{OUT} = 40 mA, C_{IN} = 0.33 μF, C_{OUT} = 0.1 μF, 0°C ≤ T_j ≤ 125°C)

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C	4.8	5.0	5.2	V
Line Regulation	Reg·line	1	T _j = 25°C	7.0 V ≤ V _{IN} ≤ 20 V	—	55	mV
				8.0 V ≤ V _{IN} ≤ 20 V	—	45	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	11	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	5.0	
Output Voltage	V _{OUT}	1	T _j = 25°C	7.0 V ≤ V _{IN} ≤ 20 V	4.75	—	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	5.25	
				1.0 mA ≤ I _{OUT} ≤ 70 mA	4.75	—	
Quiescent Current	I _B	1	T _j = 25°C	—	3.1	6.0	mA
			T _j = 125°C	—	—	5.5	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	8.0 V ≤ V _{IN} ≤ 20 V	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	0.1	
Output Noise Voltage	V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz	—	40	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—	—	12	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 8 V ≤ V _{IN} ≤ 18 V, T _j = 25°C	41	49	—	dB
Dropout Voltage	V _D	1	T _j = 25°C	—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5mA	—	– 0.6	—	mV / °C

TA78L07S

ELECTRICAL CHARACTERISTICS(Unless otherwise specified, $V_{IN} = 12\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C		6.72	7.0	7.28	V
Line Regulation	Reg·line	1	T _j = 25°C	9.2 V ≤ V _{IN} ≤ 22 V	—	50	160	mV
				10 V ≤ V _{IN} ≤ 22 V	—	45	115	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	13	75	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	6.0	40	
Output Voltage	V _{OUT}	1	T _j = 25°C	9.2 V ≤ V _{IN} ≤ 22 V	6.65	—	7.35	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA				
				1.0 mA ≤ I _{OUT} ≤ 70 mA				
Quiescent Current	I _B	1	T _j = 25°C		—	3.1	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	10 V ≤ V _{IN} ≤ 22 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output Noise Voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	50	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—		—	17	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 10 V ≤ V _{IN} ≤ 20 V, T _j = 25°C		37	46	—	dB
Dropout Voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5mA		—	−0.84	—	mV / °C

TA78L08S

ELECTRICAL CHARACTERISTICS(Unless otherwise specified, $V_{IN} = 14\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Voltage	V_{OUT}	1	$T_j = 25^\circ\text{C}$	7.7	8.0	8.3	V
Line Regulation	Reg·line	1	$T_j = 25^\circ\text{C}$	—	20	175	mV
			$10.5\text{ V} \leq V_{IN} \leq 23\text{ V}$	—	12	125	
Load Regulation	Reg·load	1	$T_j = 25^\circ\text{C}$	—	15	80	mV
			$1.0\text{ mA} \leq I_{OUT} \leq 100\text{ mA}$	—	7.0	40	
Output Voltage	V_{OUT}	1	$T_j = 25^\circ\text{C}$	7.6	—	8.4	V
			$10.5\text{ V} \leq V_{IN} \leq 23\text{ V}$	—	—	—	
			$1.0\text{ mA} \leq I_{OUT} \leq 40\text{ mA}$	7.6	—	8.4	
Quiescent Current	I_B	1	$T_j = 25^\circ\text{C}$	—	3.1	6.5	mA
			$T_j = 125^\circ\text{C}$	—	—	6.0	
Quiescent Current Change	ΔI_B	1	$T_j = 25^\circ\text{C}$	—	—	1.5	mA
			$11\text{ V} \leq V_{IN} \leq 23\text{ V}$	—	—	0.1	
Output Noise Voltage	V_{NO}	2	$T_a = 25^\circ\text{C}$, $10\text{ Hz} \leq f \leq 100\text{ kHz}$	—	60	—	μV_{rms}
Long Term Stability	$\Delta V_{OUT} / \Delta t$	1	—	—	20	—	mV / kh
Ripple Rejection	R.R.	3	$f = 120\text{ Hz}$, $12\text{ V} \leq V_{IN} \leq 23\text{ V}$, $T_j = 25^\circ\text{C}$	37	45	—	dB
Dropout Voltage	V_D	1	$T_j = 25^\circ\text{C}$, $I_{OUT} = 100\text{ mA}$	—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T_{CVO}	1	$I_{OUT} = 5\text{ mA}$	—	-0.97	—	mV / °C

TA78L09S

ELECTRICAL CHARACTERISTICS(Unless otherwise specified, $V_{IN} = 15\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C		8.64	9.0	9.36	V
Line Regulation	Reg·line	1	T _j = 25°C	11.4 V ≤ V _{IN} ≤ 24 V	—	80	200	mV
				12 V ≤ V _{IN} ≤ 24 V	—	20	160	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	17	90	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	8.0	45	
Output Voltage	V _{OUT}	1	T _j = 25°C	11.4 V ≤ V _{IN} ≤ 24 V	8.55	—	9.45	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA				
				1.0 mA ≤ I _{OUT} ≤ 70 mA	8.55	—	9.45	
Quiescent Current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	12 V ≤ V _{IN} ≤ 24 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output Noise Voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	65	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—		—	21	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 12 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	44	—	dB
Dropout Voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	– 1.09	—	mV / °C

TA78L10S

ELECTRICAL CHARACTERISTICS

(Unless otherwise specified, $V_{IN} = 16\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C		9.6	10	10.4	V
Line Regulation	Reg·line	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V	—	80	230	mV
				13 V ≤ V _{IN} ≤ 25 V	—	30	170	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	18	90	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	8.5	45	
Output Voltage	V _{OUT}	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V	9.5	—	10.5	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA				
				1.0 mA ≤ I _{OUT} ≤ 70 mA				
Quiescent Current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	13 V ≤ V _{IN} ≤ 25 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output Noise Voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	70	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—		—	22	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 13 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	43	—	dB
Dropout Voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	− 1.21	—	mV / °C

TA78L12S

ELECTRICAL CHARACTERISTICS(Unless otherwise specified, $V_{IN} = 19\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

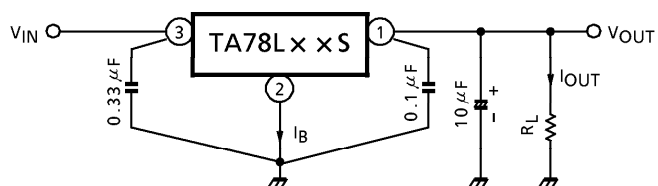
CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C		11.5	12	12.5	V
Line Regulation	Reg·line	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V	—	120	250	mV
				16 V ≤ V _{IN} ≤ 27 V	—	100	200	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	20	100	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	10	50	
Output Voltage	V _{OUT}	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V	11.4	—	12.6	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA				
				1.0 mA ≤ I _{OUT} ≤ 70 mA				
Quiescent Current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	16 V ≤ V _{IN} ≤ 27 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output Noise Voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	80	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—		—	24	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 15 V ≤ V _{IN} ≤ 25 V, T _j = 25°C		36	41	—	dB
Dropout Voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	− 1.45	—	mV / °C

TA78L15S

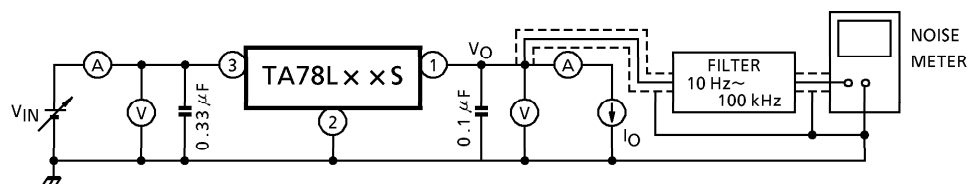
ELECTRICAL CHARACTERISTICS(Unless otherwise specified, $V_{IN} = 23\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	1	T _j = 25°C		14.4	15	15.6	V
Line Regulation	Reg·line	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V	—	130	300	mV
				20 V ≤ V _{IN} ≤ 30 V	—	110	250	
Load Regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	25	150	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	12	75	
Output Voltage	V _{OUT}	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V	14.25	—	15.75	V
				1.0 mA ≤ I _{OUT} ≤ 40 mA				
				1.0 mA ≤ I _{OUT} ≤ 70 mA	14.25	—	15.75	
Quiescent Current	I _B	1	T _j = 25°C		—	3.3	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent Current Change	ΔI _B	1	T _j = 25°C	20 V ≤ V _{IN} ≤ 30 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output Noise Voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	90	—	μV _{rms}
Long Term Stability	ΔV _{OUT} / Δt	1	—		—	30	—	mV / kh
Ripple Rejection	R.R.	3	f = 120 Hz, 18.5 V ≤ V _{IN} ≤ 28.5 V, T _j = 25°C		34	40	—	dB
Dropout Voltage	V _D	1	T _j = 25°C, I _{OUT} = 100 mA		—	1.7	—	V
Average Temperature Coefficient of Output Voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	− 1.82	—	mV / °C

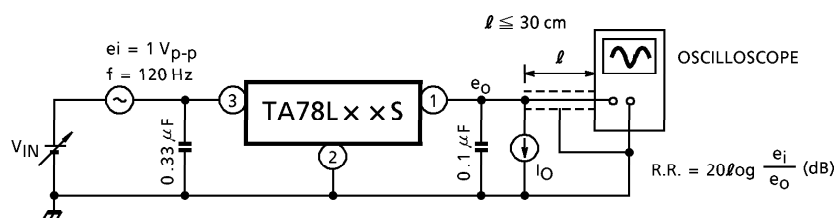
TEST CIRCUIT 1 / STANDARD APPLICATION

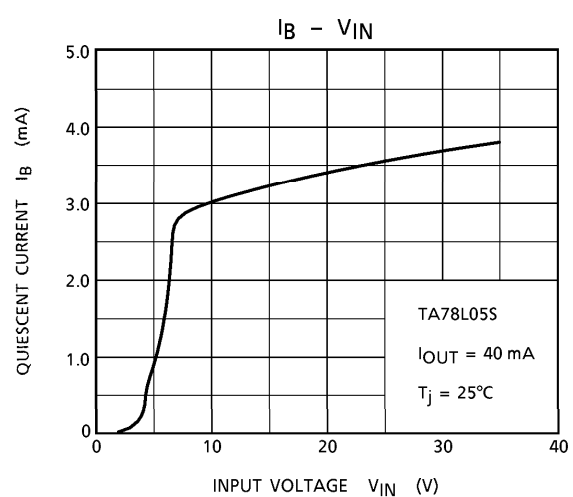
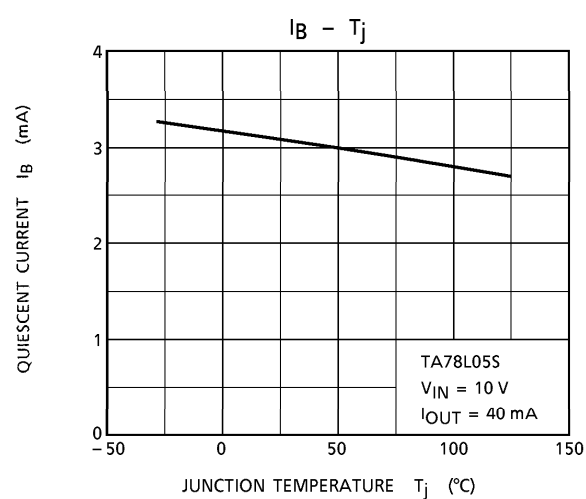
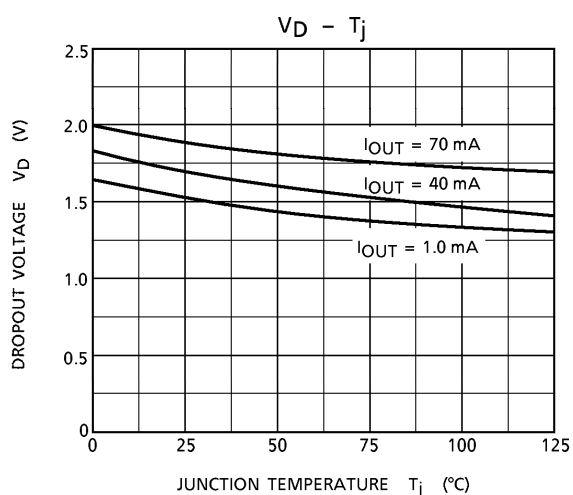
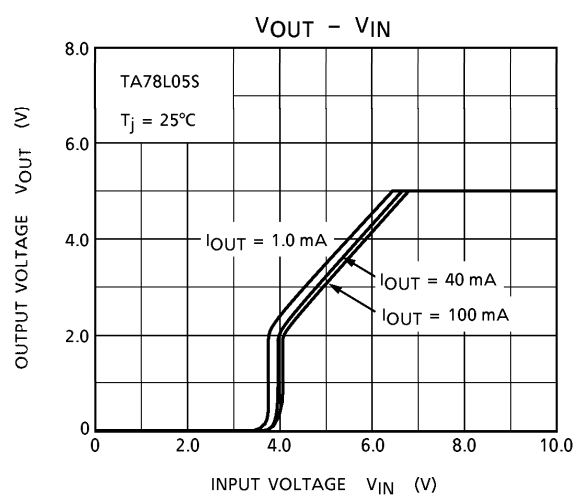
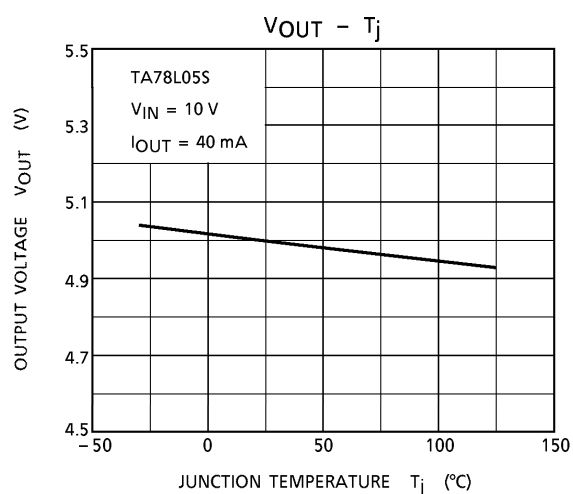
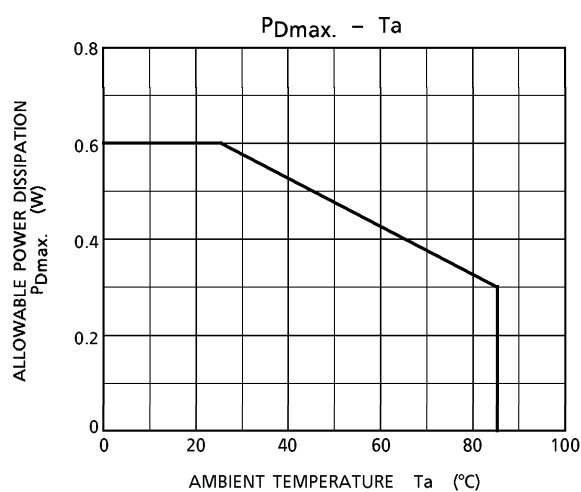


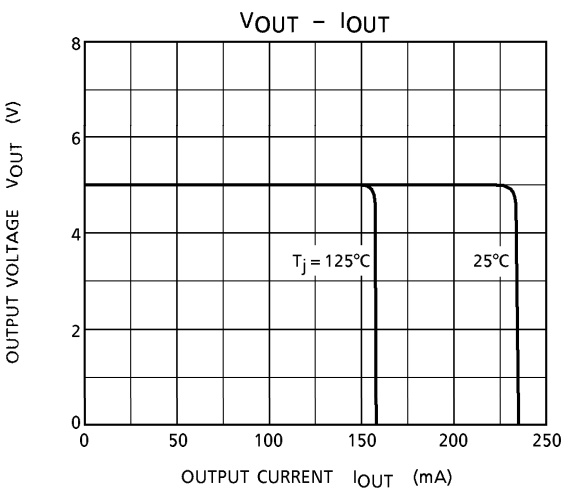
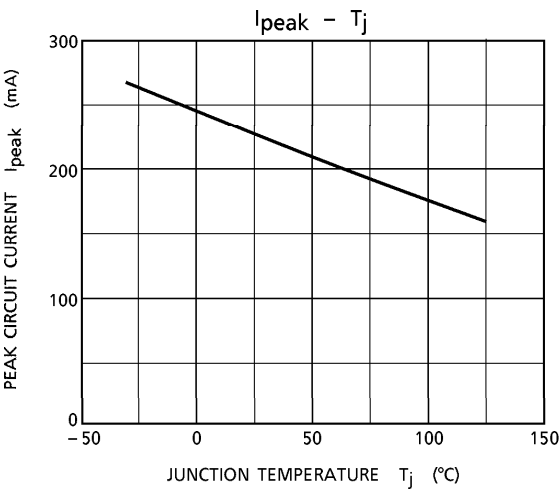
TEST CIRCUIT 2 V_{NO}



TEST CIRCUIT 3 R.R.





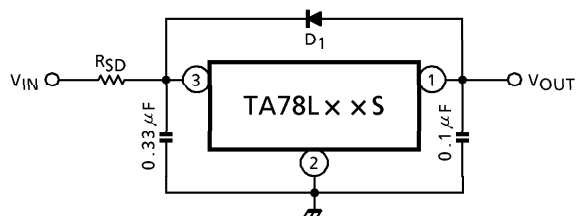


Precautions for Use

If high voltage in excess of output voltage (TYP. value) of IC is applied to its output terminal, IC may be destroyed. In this case, connect a Zener diode between the output terminal and GND to prevent application of excessive voltage. In particular, in such a current boosting circuit as shown in Application Circuit Example (2), if input voltage is suddenly applied by stages and furthermore, load is light, excessive voltage may be applied transiently to the output terminal of IC. In such a case as this, it may become necessary to increase capacity of output capacitor as appropriate, use a smaller R_1 (a resistor for bypassing IC bias current) or gradually rise input voltage in addition to use of a Zener diode as mentioned above.

APPLICATION CIRCUIT

(1) STANDARD APPLICATION



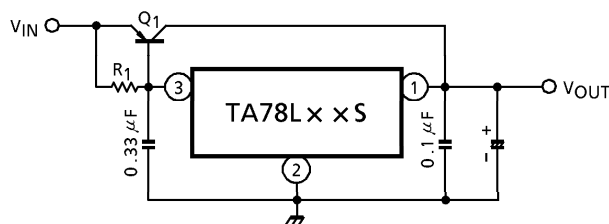
D_1 : IC protective diode

When surge voltage is applied to IC output terminal or $V_{IN} < V_{OUT}$ at the time of power ON/OFF, always connect the high speed swithing diode D_1 .

R_{SD} : Power limiting resistor

If V_{IN} is too high, always connect R_{SD} in order to reduce power consumption of IC.

(2) A. CURRENT BOOST VOLTAGE REGULATOR



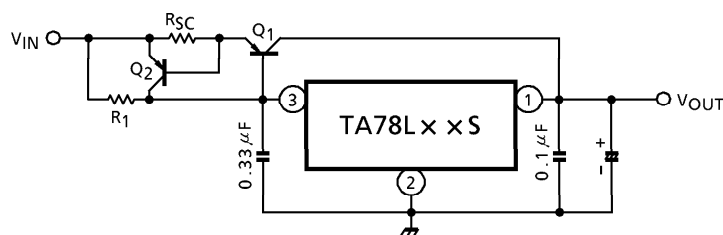
Use a required radiation plate for Q_1 .

$$R_1 \leq \frac{V_{BE1}}{I_B \text{ MAX}}$$

where, V_{BE1} : V_{BE} of external transistor Q_1 .

$I_B \text{ MAX}$: Max. bias current of IC.

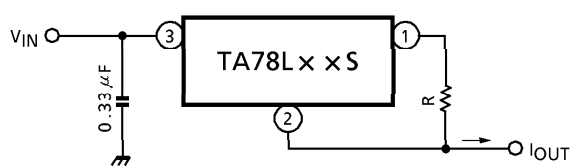
B. SHORT-CIRCUIT PROTECTION



$$R_{SC} = \frac{V_{BE2}}{I_{SC}}$$

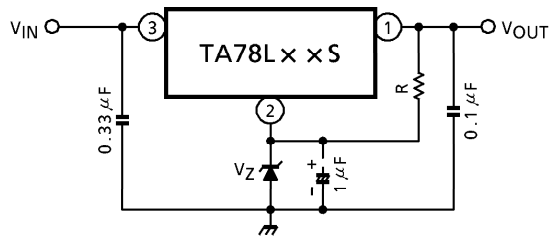
where, I_{SC} : Short-Circuit current

(3) CURRENT REGULATOR

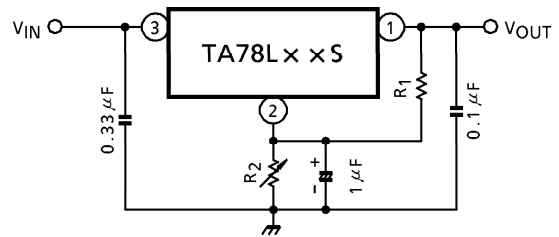


$$I_{OUT} = \frac{V_{OUT}}{R} + I_B$$

(4) VOLTAGE BOOST REGULATOR

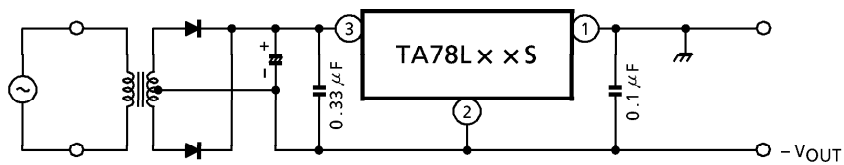


$V_{OUT} = V_Z + V_{OUT}(\text{of IC})$
Apply current of several mA to R.

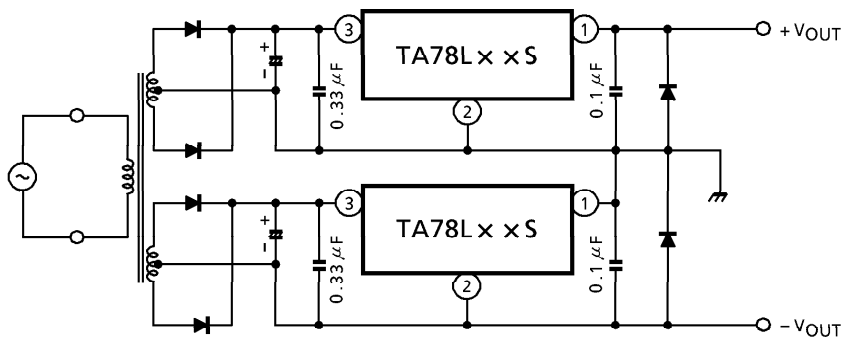


$$V_{OUT} = R_2(I_B + \frac{V_{OUT}(\text{of IC})}{R_1}) + V_{OUT}(\text{of IC})$$

(5) NEGATIVE REGULATOR

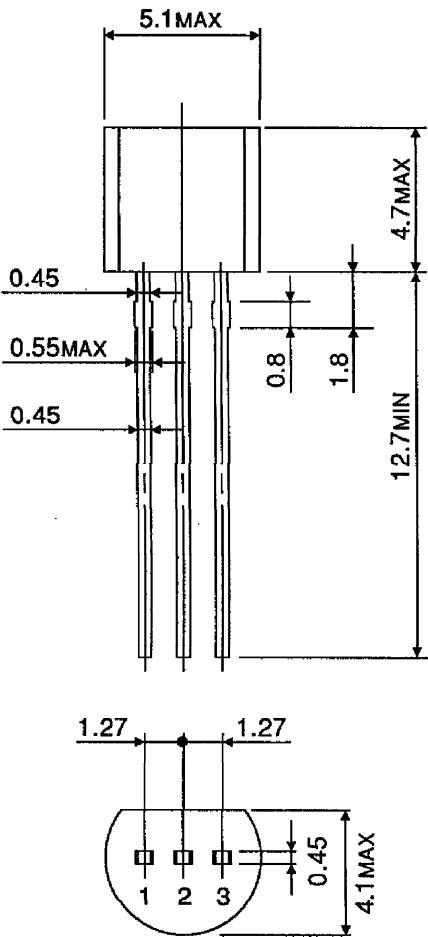


(6) POSITIVE AND NEGATIVE REGULATOR



PACKAGE DIMENSIONS
P-SSIP3-1.27A

Unit : mm



Weight : 0.21 g (Typ.)